

X2PT IGBT Module

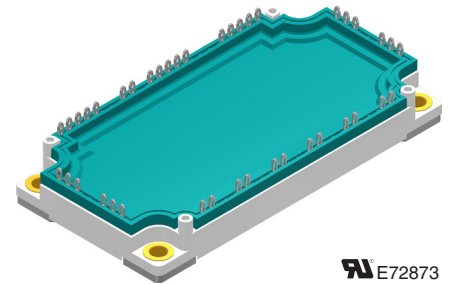
6-Pack + NTC + Shunt


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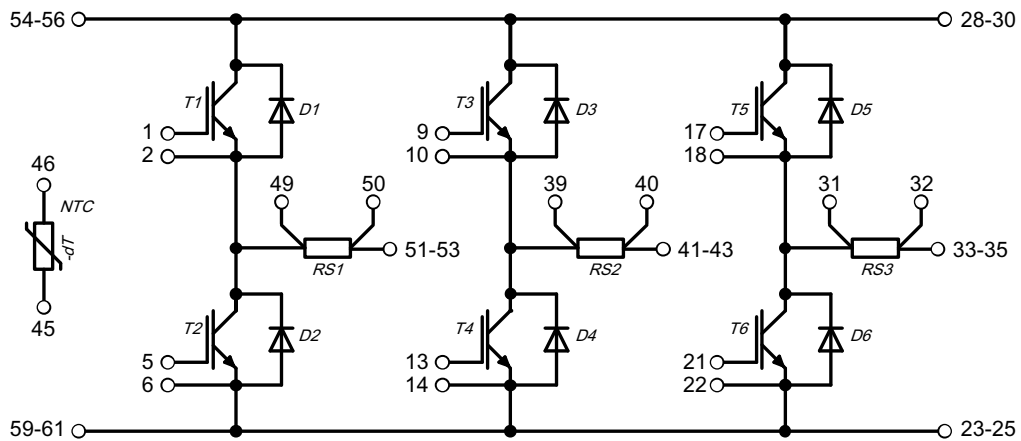
$V_{CES} = 1200 \text{ V}$
 $I_{C25} = 312 \text{ A}$
 $V_{CE(sat)} = 1.7 \text{ V}$

Part number

MIXG240W1200PZTEH



 E72873



Features / Advantages:

- X2PT - 2nd generation Xtreme light Punch Through
- $T_{Vj,m} = 175^{\circ}\text{C}$
- Easy paralleling due to the positive temperature coefficient of the on-state voltage
- Rugged X2PT design results in:
 - short circuit rated for 10 μs .
 - very low gate charge
 - low EMI
 - square RBSOA @ $2x I_c$
- Low $V_{CE(sat)}$ and low thermal resistance
- SONIC2™ diode
 - fast and soft reverse recovery
 - low operating forward voltage

Applications:

- AC motor drives
- Solar inverter
- Medical equipment
- Uninterruptible power supply
- Air-conditioning systems
- Welding equipment
- Switched-mode and resonant-mode power supplies
- Inductive heating, cookers
- Pumps, Fans

Package: E3-Pack

- Isolation Voltage: 3600 V~
- Industry standard outline
- RoHS compliant
- Base plate: Copper internally DCB isolated
- Advanced power cycling
- PressFit pins

Option:

- Phase Change Material printed on base plate

Disclaimer Notice

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Inverter IGBT T1 - T6				Ratings		
Symbol	Definitions	Conditions	min.	typ.	max.	
V_{CES}	collector emitter voltage	$I_R = 500 \mu A$	$T_{VJ} = 25^\circ C$	1200		V
V_{GES}	max. DC gate voltage			-20	+20	V
V_{GEM}	max. transient gate emitter voltage			-30	+30	V
I_{C25}	collector current		$T_C = 25^\circ C$		312	A
I_{C80}			$T_C = 80^\circ C$		233	A
I_{C100}			$T_C = 100^\circ C$		200	A
P_{tot}	total power dissipation		$T_C = 25^\circ C$		938	W
$V_{CE(sat)}$	collector emitter saturation voltage on die level	$I_C = 200 A; V_{GE} = 15 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 150^\circ C$	1.7 2	2	V V
$V_{GE(th)}$	gate emitter threshold voltage	$I_C = 8 mA; V_{GE} = V_{GE}$	$T_{VJ} = 25^\circ C$	6.0	7.5	V
I_{CES}	collector emitter leakage current (includes diode reverse current)	$V_{CE} = V_{CES}; V_{GE} = 0 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 150^\circ C$	2	0.15	mA mA
I_{GES}	gate emitter leakage current	$V_{GE} = \pm 20 V$			500	nA
R_G	internal gate resistance			6.5		Ω
C_{iss}	input capacitance	} $V_{CE} = 100 V; V_{GS} = 0 V; f = 1 MHz$		10.6		nF
C_{oss}	output capacitance					pF
C_{rss}	reverse transfer (Miller) capacitance					pF
Q_g	total gate charge	} $V_{CE} = 600 V; V_{GE} = 0 / 15 V; I_C = 200 A$		630		nC
Q_{gs}	gate source charge					nC
Q_{gd}	gate drain (Miller) charge					nC
$t_{d(on)}$	turn-on delay time	} Inductive switching $V_{CE} = 680 V; I_C = 200 A$ $V_{GE} = \pm 15 V; R_G = 3.9 \Omega$ (external) $T_{VJ} = 25^\circ C$		170		ns
t_r	current rise time			55		ns
$t_{d(off)}$	turn-off delay time			290		ns
t_f	current fall time			120		ns
E_{on}	turn-on energy per pulse			17.1		mJ
E_{off}	turn-off energy per pulse			14.2		mJ
$E_{rec(off)}$	reverse recovery losses at turn-off			4.6		mJ
$t_{d(on)}$	turn-on delay time	} Inductive switching $V_{CE} = 680 V; I_C = 200 A$ $V_{GE} = \pm 15 V; R_G = 3.9 \Omega$ (external) $T_{VJ} = 150^\circ C$		180		ns
t_r	current rise time			70		ns
$t_{d(off)}$	turn-off delay time			360		ns
t_f	current fall time			215		ns
E_{on}	turn-on energy per pulse			23.5		mJ
E_{off}	turn-off energy per pulse			20.5		mJ
$E_{rec(off)}$	reverse recovery losses at turn-off			12.2		mJ
RBSOA	reverse bias safe operating area	} $V_{GE} = \pm 15 V; R_G = 3.9 \Omega$ $V_{CEmax} = 1200 V$	$T_{VJ} = 150^\circ C$		400	A
I_{CM}						
SCSOA	short circuit safe operating area	} $V_{CEmax} = 1200 V$ $V_{CE} = 900 V; V_{GE} = \pm 15 V$ non-repetitive	$T_{VJ} = 150^\circ C$		10	μs
t_{SC}	short circuit duration				900	A
I_{SC}	short circuit current					
R_{thJC}	thermal resistance junction to case	with heatsink compound; IXYS test setup		0.24	0.16	K/W
R_{thJH}	thermal resistance junction to heatsink					K/W

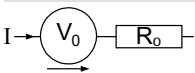
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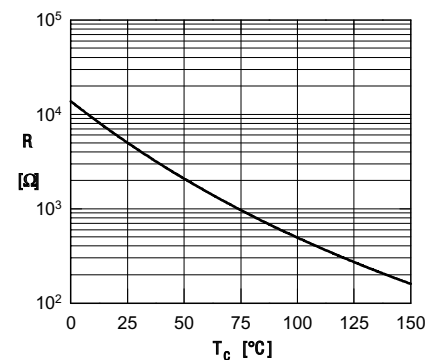
Inverter Diode D1 - D6				Ratings						
Symbol	Definitions	Conditions	min.	typ.	max.	Unit				
V_{RRM}	max. repetitive reverse voltage	$I_R = 500 \mu A$, see V_{CES}	$T_{VJ} = 25^\circ C$	1200		V				
I_{F25} I_{F80} I_{F100}	forward current		$T_C = 25^\circ C$ $T_C = 80^\circ C$ $T_C = 100^\circ C$		189 136 114	A				
V_F	forward voltage on die level	$I_F = 200 A$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 150^\circ C$	1.87 1.85	2.2 2,2	V				
I_R	reverse current * not applicable, see I_{ces} at IGBT	$V_R = V_{RRM}$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 150^\circ C$	*	*	mA mA				
Q_{RM} I_{RM} t_{tr} di/dt E_{rec}	reverse recovery charge max. reverse recovery current reverse recovery time rate of change of current reverse recovery energy	$V_{CE} = 600 V$; $I_C = 200 A$ $V_{GE} = \pm 15 V$; $R_G = 3.9 \Omega$ (external)	$T_{VJ} = 25^\circ C$		12 170 240 4200 4.6	μC A ns A/ μs mJ				
Q_{RM} I_{RM} t_{tr} di/dt E_{rec}	reverse recovery charge max. reverse recovery current reverse recovery time rate of change of current reverse recovery energy			$V_{CE} = 600 V$; $I_C = 200 A$ $V_{GE} = \pm 15 V$; $R_G = 3.9 \Omega$ (external)	$T_{VJ} = 150^\circ C$		26 195 480 3600 12.2	μC A ns A/ μs mJ		
R_{thJC} R_{thJH}	thermal resistance junction to case thermal resistance junction to heatsink					with heatsink compound; IXYS test setup		0.48	0.38	K/W K/W

Shunt Resistor				Ratings		
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
R_{SHUNT}	resistance temperature coefficient		$T_C = 25^\circ C$	0.495	0.500 50	m Ω ppm/K
R_{thSH}	thermal resistance shunt to heatsink	with heatsink compound; IXYS test setup *		10		K/W

* Note: Continuous shunt temperature should not exceed 170°C

Temperature Sensor NTC						
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
R_{25}	resistance	$T_{VJ} = 25^\circ C$	4.75	5.0	5.25	k Ω
$B_{25/50}$	temperature coefficient			3375		K

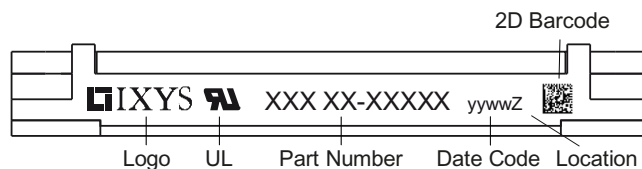
Equivalent Circuits for Simulation <small>*on die level</small>			
		IGBT	Boost Diode
	V_{0max}		
	R_{0max}		
	V_{0max}		
	R_{0max}		



Typ. NTC resistance vs. temperature

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Package	E3-Pack	Symbol	Definitions	Conditions	Ratings			Unit
					min.	typ.	max.	
		I_{RMS}	RMS current	per terminal			30	A
		T_{stg}	storage temperature		-40		125	°C
		T_{op}	operation temperature		-40		150	°C
		T_{vJ}	virtual junction temperature		-40		175	°C
Weight							320	g
		M_D	mounting torque		3		6	Nm
		d_{Spp}	creepage distance on surface	terminal to terminal	6.0			mm
		d_{Spb}		terminal to backside	12.0			mm
		d_{App}	striking distance through air	terminal to terminal	6.0			mm
		d_{Apb}		terminal to backside	12.0			mm
		V_{ISOL}	isolation voltage	t = 1 second t = 1 minute	4300 3600	50 / 60 Hz, RMS; $I_{ISOL} \leq 1$ mA		V V
		$R_{pin-chip}$	resistance pin to chip	$V = V_{CEsat} + 2 \cdot R \cdot I_C$ resp. $V = V_F + 2 \cdot R \cdot I_F$				mΩ
		C_p	coupling capacity per switch	between shorted pins of switch and back side metallization				pF

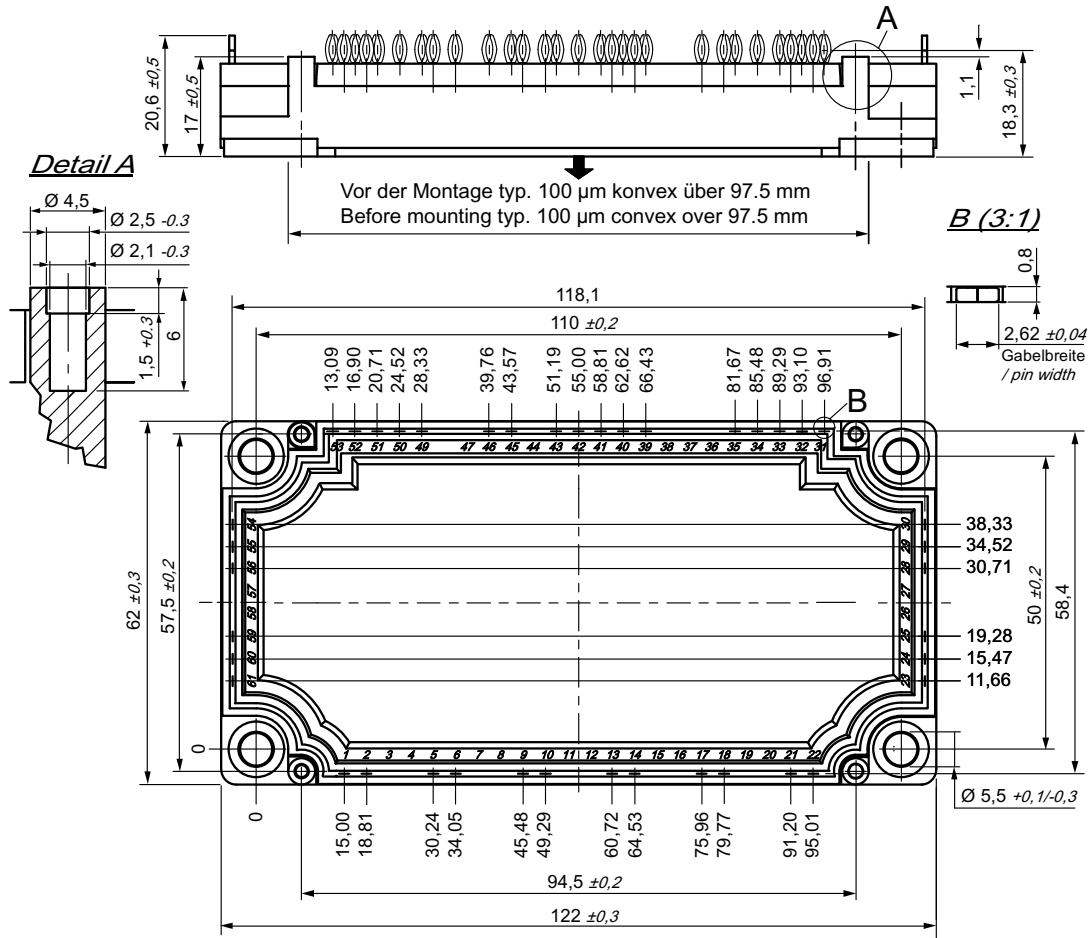

Part number

M = Module
 I = IGBT
 X = XPT IGBT
 G = Gen 2 / std
 240 = Current Rating [A]
 W = 6-pack
 1200 = Reverse Voltage [V]
 PZT = PressFit Pin + Shunt 0.5mΩ, Thermistor
 EH = E3-Pack

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standard	MIXG240W1200PZTEH	MIXG240W1200PZTEH	Blister	24	MIXG240W1200PZTEH
with Phase Change Material	MIXG240W1200PZTEH -PC ¹⁾	MIXG240W1200PZTEH	Blister	24	

Similar Part	Package	Voltage class
MIXG240W1200TEH	E3- Pack	1200
MIXG240W1200PTEH ²⁾	E3- Pack, press fit pin	1200

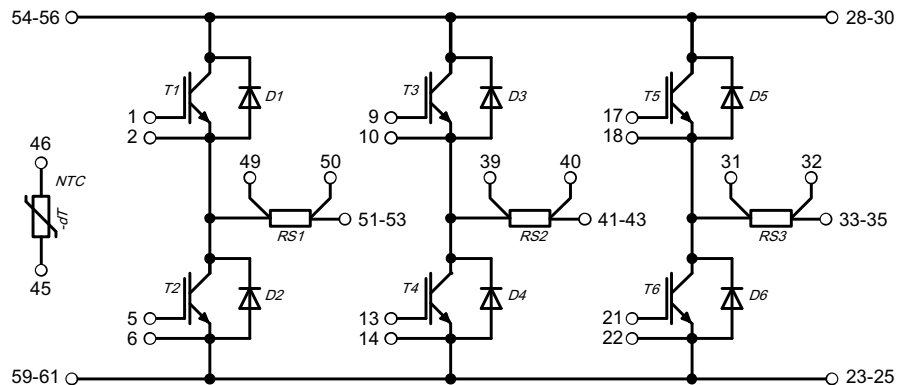
Options: ¹⁾ phase change material and ²⁾ press fit pin
 Please contact Littelfuse - IXYS sales office for availability

Outlines E3-Pack

Bemerkung / Note:

- Nichttolerierete Maße nach / Measure without tolerances according DIN ISO 2768-T1-m
- PCB-Lochmuster / PCB hole pattern: **see pin position**
- Toleranz Pin-Position und PCB-Lochmuster / Tolerance of pin position and PCB hole pattern: $\oplus 0.1$
- Bohrlochdurchmesser / Diameter of drill: $\varnothing 2.35$ mm
- Endlochdurchmesser / Diameter of plated holes: $\varnothing 2.14 - 2.29$ mm (Cu thickness in via typ. 50 µm)
- Beschichtung / Plating: **chem. Sn max. 15 µm**
- Einpresskraft / Insert Force: per terminal with a typ. insert speed of 7 mm/s: **typ. 90 N**
- Weitere Angaben / Further information: www.ixys.com **Application note IXAN0077**
- Montageanleitung / Mounting instruction: www.ixys.com **Application note IXAN0024**

Detail A: PCB-Montage / Mounting on PCB

- Empfohlene, selbstschneidende Schraube / Recommended, self-tapping screw: **EJOT PT®** (Größe / size: **K25**)
- Max. Schraubenlänge / Max. screw length: **PCB-Dicke / thickness + 6 mm** (max. Lochtiefe / hole depth)
- Empfohlenes Drehmoment / Recommended mounting torque: **1.5 Nm**



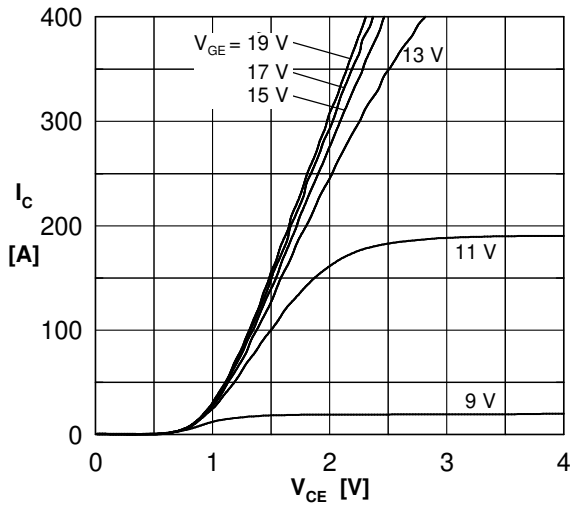
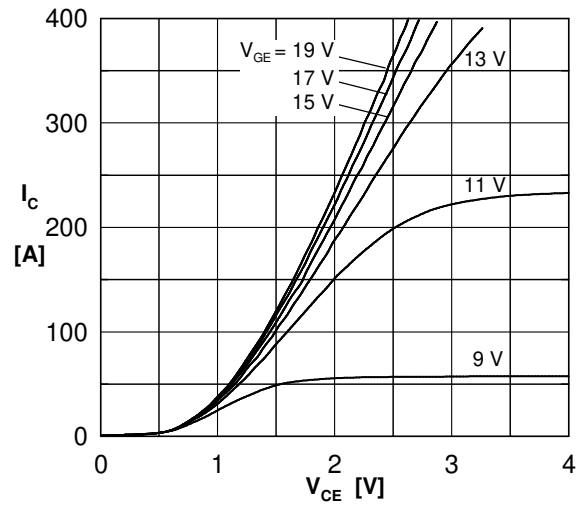
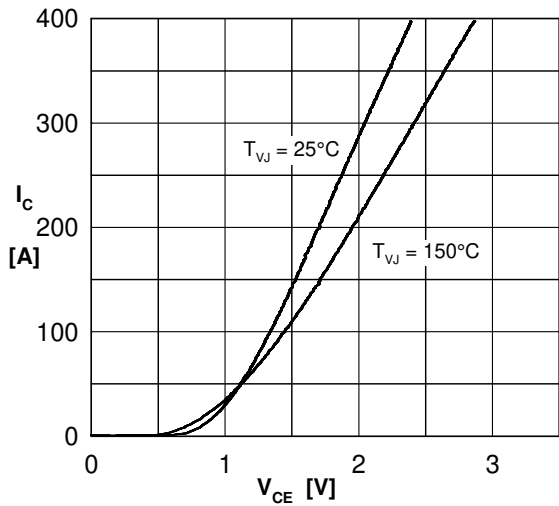
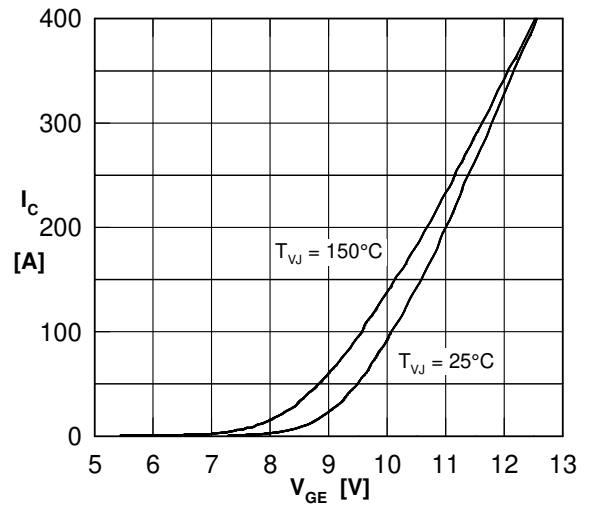
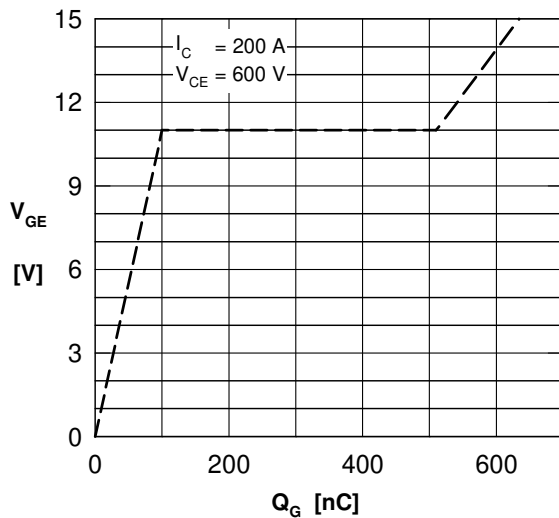
IGBT T1 - T6

 Fig. 1 Typ. output characteristics ($T_{VJ} = 25^{\circ}\text{C}$)

 Fig. 2 Typ. output characteristics ($T_{VJ} = 150^{\circ}\text{C}$)

 Fig. 3 Typ. output characteristics ($V_{GE} = 15\text{V}$)

 Fig. 4 Typ. transfer characteristics ($V_{CE} = 20\text{V}$)


Fig. 5 Typ. turn-on gate charge 0/15V

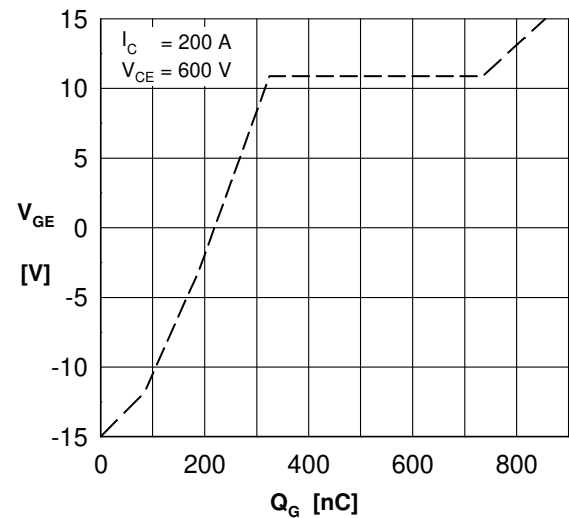


Fig. 6 Typ. turn-on gate charge -15/+15V

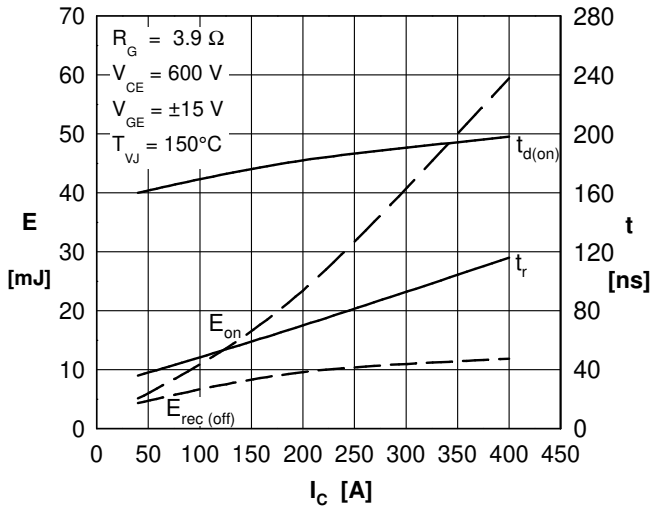
IGBT T1 - T6


Fig. 7 Typ. switching energy versus collector current (turn on)

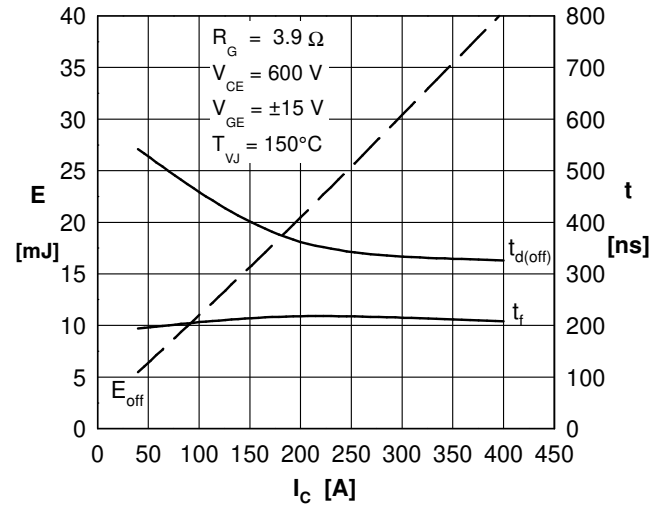


Fig. 8 Typ. switching energy versus collector current (turn off)

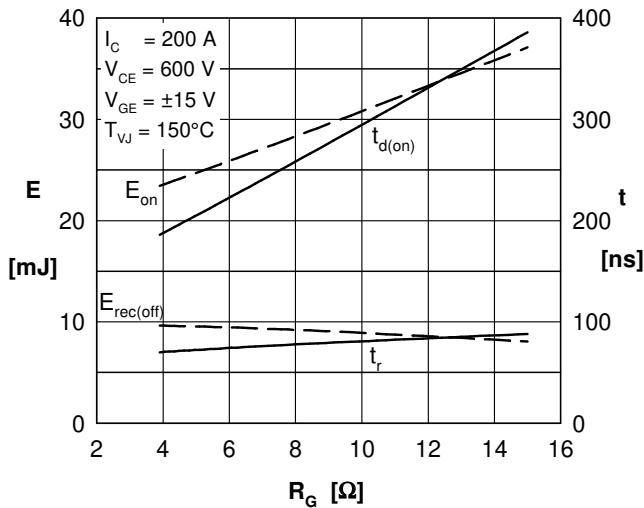


Fig. 9 Typ. switching energy versus gate resistor (turn on)

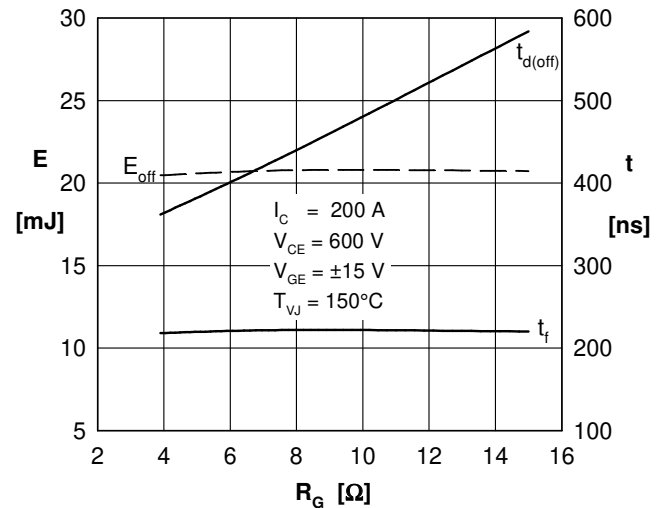


Fig. 10 Typ. switching energy versus gate resistor (turn off)

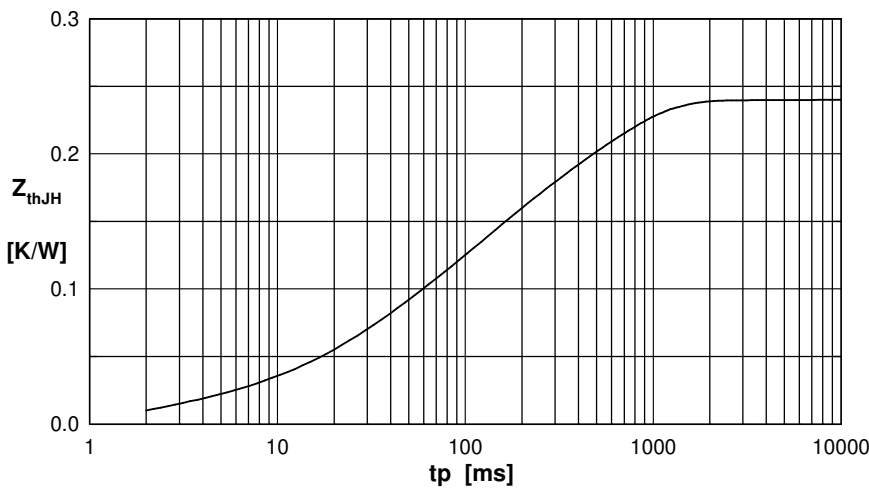


Fig. 11 IGBT: typ. transient thermal impedance to heat sink

DIODE D1 - D6

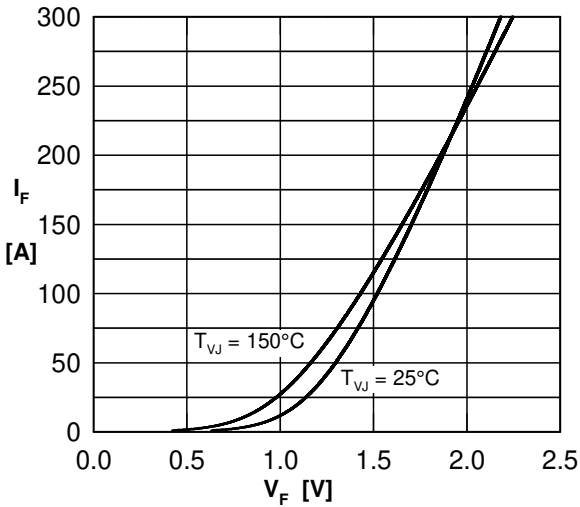


Fig. 12 Typ. forward characteristics FWD

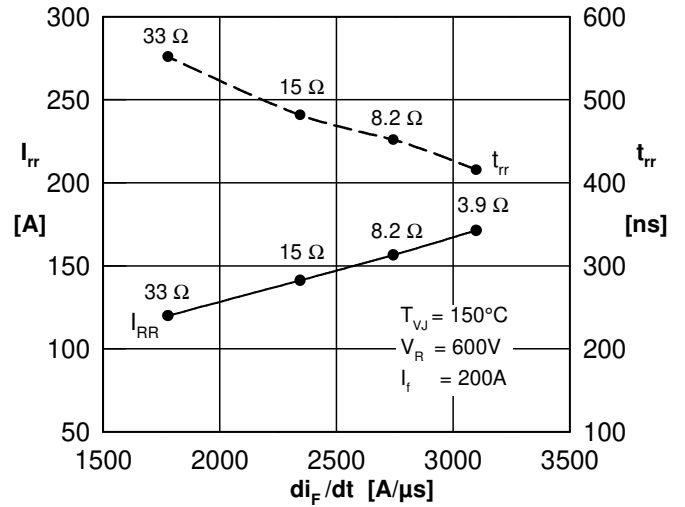


Fig. 13 Typ. recovery energy $E_{rec(off)}$ versus $-di/dt$

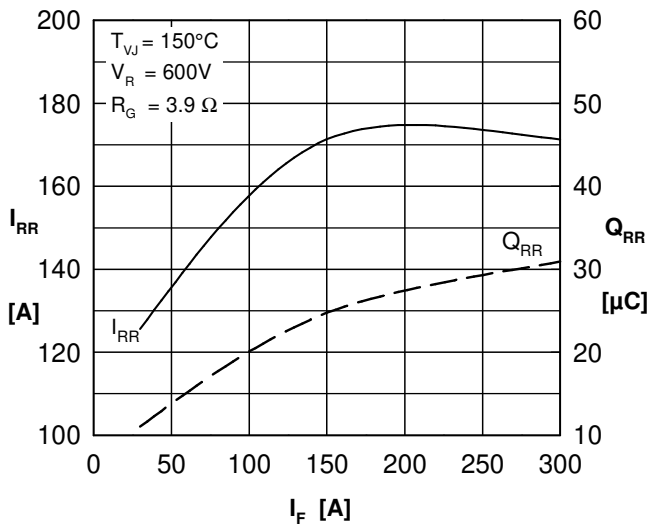


Fig. 14 typ. reverse recovery characteristics

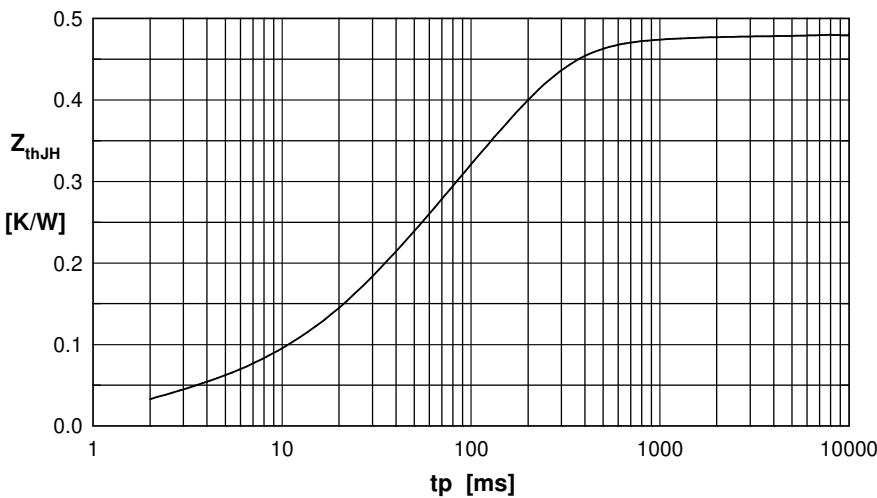


Fig. 15 Diode: typ. transient thermal impedance junction to heat sink